

Search Notes

Application/Control No.

10/536,925

Examiner

Ka Chun Leung

Applicant(s)/Patent under
Reexamination

DEISS ET AL.

Art Unit

3747

SEARCHED

| Class | Subclass | Date | Examiner |
|---------|----------|-----------|----------|
| 123 | 184.55 | 1/31/2007 | KCL |
| 123 | 184.21 | 1/31/2007 | KCL |
| 123 | 184.53 | 1/31/2007 | KCL |
| Updated | Above | 5/9/2007 | KCL |
| 123 | 184.55 | 5/9/2007 | KCL |
| 123 | 184.56 | 5/9/2007 | KCL |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-----------------------|----------|-----------|----------|
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| See EAST search notes | | 5/10/2007 | KCL |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| See attached EAST search notes | 2/1/2007 | KCL |
| Searched related internation classification: F02M 35/10 and F02B 27/02 | 5/10/2007 | KCL |
| Reviewed PLUS search results | 5/10/2007 | KCL |
| Search suggestions from Hai Huynh: No additional class/sub | 5/10/2007 | KCL |
| See updated EAST search notes | 5/10/2007 | KCL |
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